

**Search Notes**

Application/Control No.

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Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

PERKINS ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
174	66	7/28/2006	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
174	as above	7/28/2006	LEE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached text search	7/28/2006	LEE